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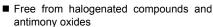
October 2016

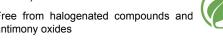
FDMA008P20LZ

Single P-Channel PowerTrench® MOSFET -20 V, -2.5 A, 13 mΩ

Features

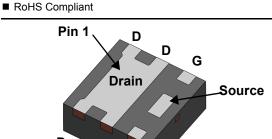
- Max $r_{DS(on)}$ = 13 m Ω at V_{GS} = -4.5 V, I_D = -2.5 A
- Max $r_{DS(on)}$ = 16 m Ω at V_{GS} = -2.5 V, I_D = -1.4 A
- Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = -1.8 V, I_D = -1.0 A
- Max $r_{DS(on)}$ = 30 m Ω at V_{GS} = -1.5 V, I_D = -0.85 A
- Low Profile 0.8 mm maximum in the new package MicroFET
- HBM ESD protection level > 1k V typical

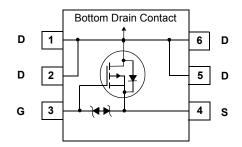




General Description

This device is designed specifically for battery charge or load switching in cellular handset and other ultraportable applications. It features a MOSFET with low on-state resistance and zener diode protection against ESD. The MicroFET 2X2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications.





MicroFET 2X2 (Bottom View)

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V_{DS}	Drain to Source Voltage			-20	V	
V_{GS}	Gate to Source Voltage			±8	V	
	-Continuous	T _A = 25°C	(Note 1a)	-2.5	^	
^I D	-Pulsed		(Note 5)	-164	Α	
E _{AS}	Single Pluse Avalanche Energy		(Note 4)	54	mJ	
D	Power Dissipation	T _A = 25°C	(Note 1a)	2.4	W	
P_D	Power Dissipation $T_A = 25^{\circ}C$ (Note 1b)		(Note 1b)	0.9	vv	
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMA008P20LZ	FDMA008P20LZ	MicroFET 2X2	7"	8 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					•
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		-16		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V			-1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±1	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.4	-0.65	-1.4	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		3		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -2.5 \text{ A}$		10	13	- mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -1.4 \text{ A}$		12	16	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$		15	20	
r _{DS(on)}		$V_{GS} = -1.5 \text{ V}, I_D = -0.85 \text{ A}$		20	30	
		$V_{GS} = -4.5 \text{ V}, I_D = -2.5 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		12.8		
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_D = -2.5 \text{ A}$		26		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	3131	4383	pF
Coss	Output Capacitance		424	594	pF
C _{rss}	Reverse Transfer Capacitance		386	540	pF
R_g	Gate Resistance		13	25	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	.,	12	21	ns
t _r	Rise Time	V_{DD} = -10 V, I_{D} = -2.5 A, V_{GS} = -4.5 V, R_{GEN} = 6 Ω	17	30	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = -4.5 V, R _{GEN} = 6 12	239	382	ns
t _f	Fall Time		96	153	ns
Qg	Total Gate Charge	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$	28	39	nC
Q _{gs}	Gate to Source Charge	I _D = -2.5 A	3.6		nC
Q _{nd}	Gate to Drain "Miller" Charge		6.2		nC

Drain-Source Diode Characteristics

V _{SD}	Source to Drain Dioge Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -2 \text{ A}$ (Note 2)	-0.6	-1.2	V
		$V_{GS} = 0 \text{ V}, I_S = -2.5 \text{ A}$ (Note 2)	-0.8	-1.3	V
t _{rr}	Reverse Recovery Time	I _E = -2.5 A, di/dt = 100 A/μs	28	46	ns
Q _{rr}	Reverse Recovery Charge	1F = -2.5 A, α//αt = 100 A/μs	10	17	nC

NOTES

^{1.} $R_{\theta,JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,JA}$ is determined by the user's board design.



a. 52 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 145 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

^{3.} The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

^{4.} E_{AS} of 54 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 6 A, V_{DD} = 20 V, V_{GS} = 4.5 V. 100% test at L = 0.1 mH, I_{AS} = 19 A.

^{5.} Pulsed Id please refer to Fig.10 SOA curve for more details.

Typical Characteristics T_J = 25 °C unless otherwise noted

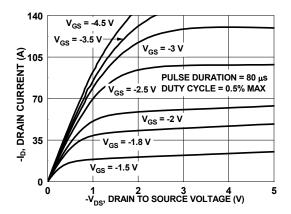


Figure 1. On-Region Characteristics

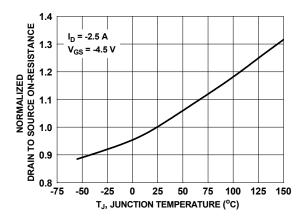


Figure 3. Normalized On-Resistance vs Junction Temperature

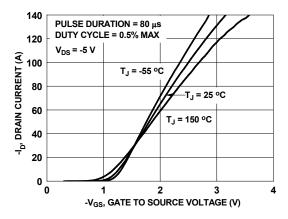


Figure 5. Transfer Characteristics

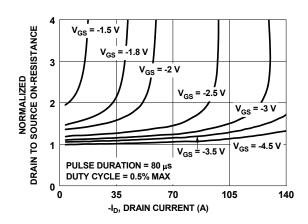


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

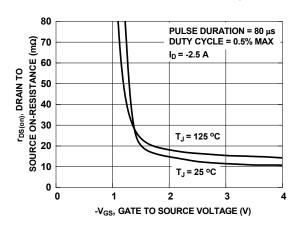


Figure 4. On-Resistance vs Gate to Source Voltage

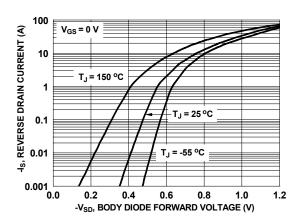


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

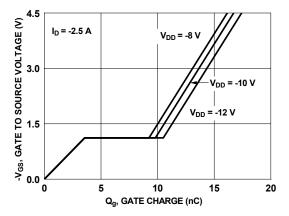


Figure 7. Gate Charge Characteristics

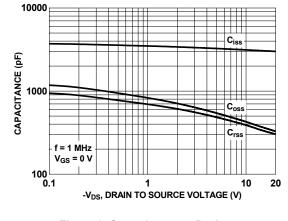


Figure 8. Capacitance vs Drain to Source Voltage

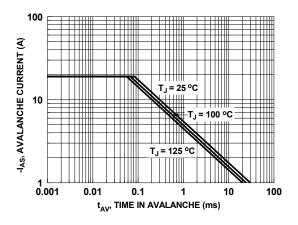


Figure 9. Unclamped Inductive Switching Capability

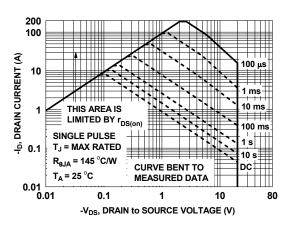


Figure 10. Forward Bias Safe Operating Area

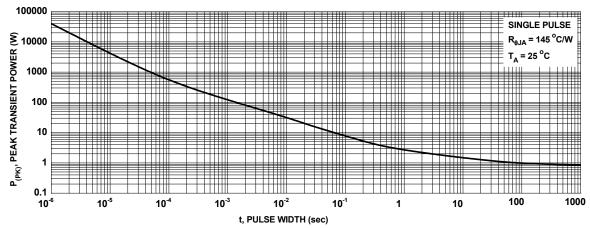


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

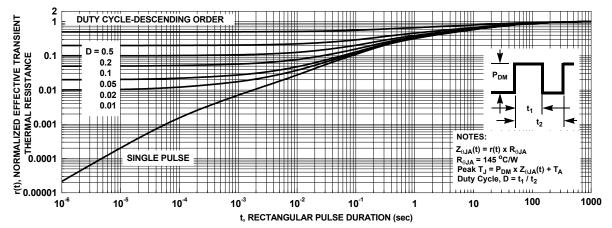
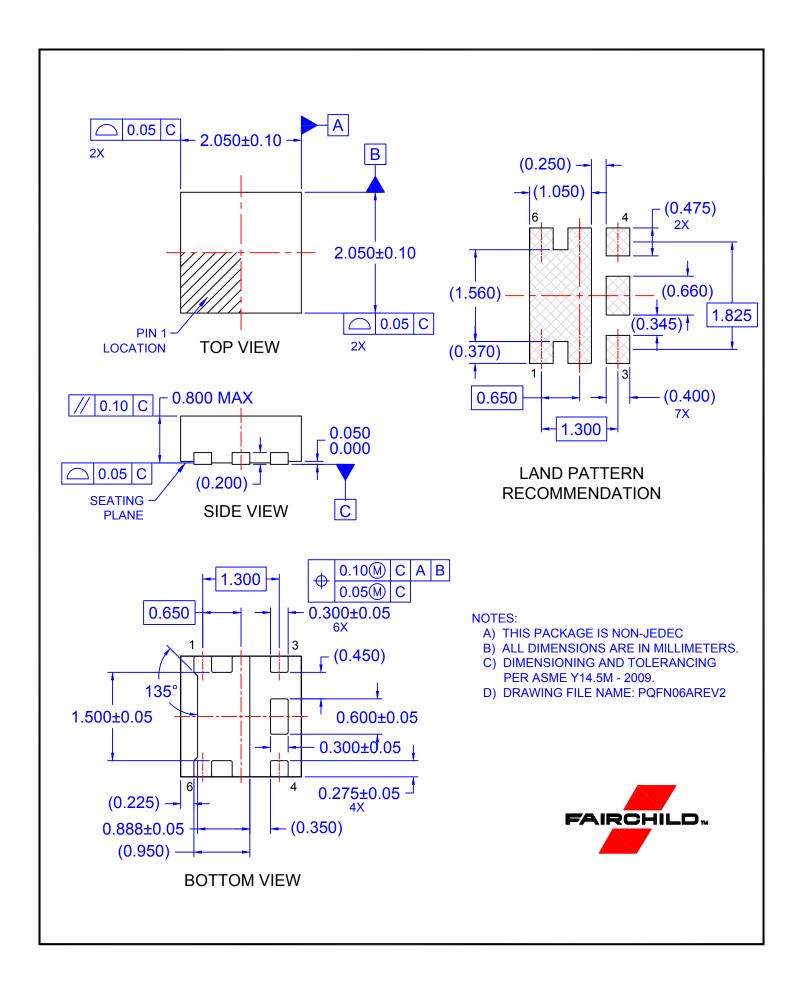


Figure 12. Junction-to-Ambient Transient Thermal Response Curve



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